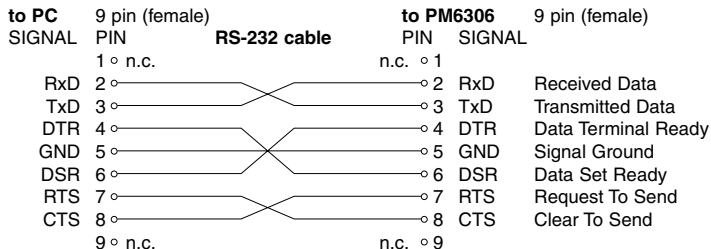


IEEE-488 INTERFACE

AH1 acceptor handshake
SH1 source handshake
L4 listener function
T6 talker function
RL1 local/remote
 with local lockout
SR1 service request (SRQ)
DC1 device clear
DT1 device trigger
PPO no parallel poll
CO no controller function
E2 tri-state drivers

Addresses: 1 to 30

RS-232 INTERFACE



Baud rate: 110, 150, 300, 600, 1200, 2400, 4800, 9600, 19200

Data bits: 7 or 8

Stop bits: 1 (2 for 110 baud only)

Parity: odd, even or no

Xon/Xoff handshake: on or off

Hardware connection: 3 or 7 wires

Hardware handshake: DSR/DTR or CTS/RTS

Special Interface Functions

Common Commands and Queries in Accordance with IEEE-488.2

| | |
|--------------------------------------|---------------|
| IEEE-488 | RS-232 |
| GTL go to local | ESC 1 |
| GTR go to remote control | ESC 2 |
| DCL device clear | ESC 4 |
| LLO local lockout | ESC 5 |
| * STB? read status byte query | ESC 7 |
| DTR device trigger | ESC 8 |

- ★ **CLS** Clear Status Command
- ★ **ESE** Event Status Register Enable
- ★ **ESR?** Standard Event Status Register Query
- ★ **IDN?** Identification Query
- ★ **LRN?** Learn Mode
- ★ **OPC** Operation Complete Command
- ★ **RCL** Recall Command

- ★ **RST** Reset Command
- ★ **SAV** Save Command
- ★ **SRE** Service Request Enable
- ★ **STB?** Read Status Byte
- ★ **TRG** Trigger Command
- ★ **TST?** Selftest Query
- ★ **WAI** Wait-to-Continue

Device Specific Commands

Normal operation:

MODE? asks for measurement mode
AUTO automatic measurement mode
SER sets serial measurement mode
PARAL sets parallel measurement mode
PARAM? asks for selected parameter
PARAM QUA quality factor is displayed
PARAM DISS dissipation factor is displayed
PARAM PHA phase angle is displayed
PARAM IMP impedance is displayed
PARAM VOL voltage is displayed
PARAM CUR current is displayed
PARAM AUTO sets to mode selected before
FRE <Nrf> sets test signal frequency
FRE? asks for test signal frequency
AC_LEV <Nrf> sets AC test signal level
AC_LEV? asks for AC test signal level
DC_LEV <Nrf> sets DC test signal level
DC_LEV? asks for DC test signal level
DC_BIAS? asks for DC bias
DC_BIAS OFF DC bias off
DC_BIAS INT DC bias internal
DC_BIAS EXT DC bias external
BIAS_VOL <Nrf> sets internal DC bias voltage
BIAS_VOL? asks for DC bias voltage level
TEST_SIG? asks for test signal
TEST_SIG AC AC test signal
TEST_SIG DC DC test signal
SET_FIX? asks for correction factor
SET_FIX <Nrf> sets correction factor for ground capacitance
AVG? asks for averaging
AVG <Nrf> increased averaging
AVG OFF normal averaging
TRIM SINGLE open/short - circuit trimming
TRIM ALL

CONTA_CHE contact check
DEV OFF switches DEVIATION mode off
DEV ON switches DEVIATION mode on
DEV? asks if DEVIATION is on or off
REF_CAP <Nrf> sets capacitance reference value
REF_INDU <Nrf> sets inductance reference value
REF_RESI <Nrf> sets resistance reference value
SET_REF sets current parameter and value for reference
REF? asks for reference
COM? asks for component parameters
RESI? asks for resistance value
CAP? asks for capacitance value
INDU? asks for inductance value
IMP? asks for impedance value
QUAL? asks for quality factor value
DISS? asks for dissipation factor value
PHA? asks for phase angle value
VOL? asks for measured voltage
CUR? asks for measured current
DEV_RES? asks for deviation in %
CONTI continuous measurements
SIN single measurement
TRIG starts single measurement
POS_FIX? asks for fixed parameter
POS_FIX R fixes to resistance
POS_FIX C fixes to capacitance
POS_FIX L fixes to inductance
POS_FIX CL fixes to capacitances or inductances
POS_FIX OFF switches the function off
POS_FIX ON switches the function on
MEA_FAST? asks for fast measurement
MEA_FAST ON fast measurement on
MEA_FAST OFF fast measurement off
ERR? asks for error message

Binning:

BIN ON binning mode on
BIN OFF normal measurement mode
BIN <Nrf> allocates data to selected bin
BIN? asks for the bin the component is allocated to
BIN_DIS <Nrf> disables selected bin
BIN_EN <Nrf> enables selected bin
BIN_SET? <Nrf> asks for selected bin set
BUF_BIN? <Nrf> asks for the selected bin from the buffer for editing
BUF_CLR deletes buffer for editing
BIN_ELA <Nrf> deletes selected bin set
BIN_STO <Nrf> stores bin set
BIN_RCL <Nrf> loads bin set into register 0 for binning
BUF_RCL <Nrf> loads bin set into buffer for editing
BIN_ABS input of absolute value
BIN_REL nominal value, tolerance in %
RESI <Nrf> resistances, nominal
CAP <Nrf> capacitances, nominal
INDU <Nrf> inductances, nominal
IMP <Nrf> impedances, nominal
QUAL <Nrf> quality factor, normal
DISS <Nrf> dissipation factor, nominal
PHA <Nrf> phase angle, nominal
 for input of absolute values skip <Nrf>
LIM_HI <Nrf> upper limit
LIM_LO <Nrf> lower limit
 <Nrf> means flexible numeric representation,
 e.g. RESI 1000 or RESI 1000.0 or
 RESI 1.0E3 for 1 kΩ